Convective assembly of silica colloidal particles inside of photonic integrated chip based microfluidic systems for gas sensing applications

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22 S1. SURFACE COVERAGE ESTIMATIONS USING THE OTSU ALGORITHM

23 The surface coverage of the silica layers on Si_3N_4 the surface were processed using openCV Python package, version 3.3.9.7. Otsu

24 thresholding^{s1} with the minor code modifications. Feng *et al.* also implemented the OTSU algorithm to estimate the surface

25 coverage of the monolayer films.⁵² The empty locations between the silica particles were designated as a background. As show in

26 Fig. S1, following the conversion of an RGB SEM image to a gray scale image, a combination of binary conversion and Otsu's

27 algorithm was applied.





29 Fig. S1. Representation of processing a grayscale SEM image to a binary one by Otsu thresholding.

30 A grayscale image can be considered as a 2D matrix containing pixel values in the range of [0; 255], where 0 refers to black, and

31 255 refers to white. Then, a processed image undergoes several iterations of operations 'erode' and 'dilate'. The 'erode' operation

32 helps in removing noises in the images, i.e., the other shades, and smooths out the pixels with most abundant pixel value. When

33 'erode' operation is applied, it removes the unnecessary white pixels from the background, while the use of 'dilate' function,

34 which considers the background as noise, helps in eliminating the black pixels from the regions representing spherical particles.



35

36 Fig. S2. Use of Otsu thresholding to a hcp silica monolayer.

We considered 5 to 10 images, where each image was obtained from a different number of 'dilate' iterations. After comparing the binary images with the original image, three images were selected. The final fill factor was the mean of fill factors calculated from these three images. Here, it is worth noting that the number of iterations for 'dilate' function can greatly influence on the fill factor. Thus, the decision if the binary image fits with the actual SEM image or not, solely depends upon the judgement of the

41 user. This puts the factor of human error into the calculations. The use of this method for a binary image of a *hcp* monolayer of

42 spherical silica particles (see **Fig. S2**) depicts a coefficient of surface coverage of 92 \pm 3 % (*n*=3, *P*=0.95). This agrees well with the

$$\frac{\pi}{2\sqrt{2}} \approx 90.7$$
 %

43 value of an ideal *hcp* monolayer, which is equal to $2\sqrt{3}$. However, poor contrast between substrate and particle 44 monolayers in SEM images will be a disadvantage of this method since it will be difficult to trace the boundaries between void 45 and coated regions.

46 S2. SUBSTRATE FABRICATION

47 We fabricated microfluidic channels by using soft lithography. The microfluidic chip contained polydimethylsiloxane (PDMS)

48 channels with a square shaped cross-section 500 μm imes 500 μm . A master-form of the microfluidic chip was obtained on acrylic

- 49 plastic by using computer numerical control milling. To produce PDMS, a mixture of silicon elastomer and curing agent at a 10:1 50 ratio was prepared. To remove air-bubbles from PDMS prior to baking, the prepared mixture was placed inside the master-form
- 50 ratio was prepared. To remove air-bubbles from PDMS prior to baking, the prepared mixture was placed inside the master-form
- 51 structure and into a low vacuum chamber. The master-form containing PDMS was then baked at 60 $^{\circ}$ C for four hours. PDMS was
- 52 then removed and washed with ethanol prior to its combination with the photonic chip.
- 53 For the fabrication of micro-ring resonators (MRRs), commercially available silicon nitride (Si₃N₄) substrates consisted of a 450 nm
- 54 of low-pressure chemical vapour deposition Si₃N₄ on top of a silicon substrate with an initial 2.6 μm thick layer of SiO_2 . For
- 55 waveguide formation, electron beam lithography and then partial etching was done by using reactive ion etching (Fig. S3a). This
- resulted in 180 nm of partially etched rib waveguides (Fig. S3b) and focusing grating couplers (Fig. S3c). The fabricated photonic
- 57 circuit had eight non-intersecting ring resonators with ring radius of 150 μm . The MRRs also had varying coupling gaps between
- 58 bus and ring waveguides, i.e., 500 nm, 650 nm, 800 nm and 1000 nm. The MRRs in the opposite row had identical coupling gaps.
- 59 The fabrication process was controlled with SEM and AFM techniques (Fig. S3d).



60

61 Fig. S3. Micro-ring resonator characterization. (a) SEM image of MRR. (b) SEM image of mode coupling gap region of MRR. (c)

62 SEM image of focusing grating coupler. (d) AFM topography of gap region depicting the etching depth of less than 200 nm for

63 photonic structures.

64 S3. DIP COATING

65 **Silicon nitride substrate cleaning protocol.** Firstly, the contaminated surface was thoroughly washed with distilled water, followed 66 by drying in the inert atmosphere. Then, to remove organic impurities from the surface, the following cleaning protocol was 67 carried out: washing alternately with acetone (99.8%, EKOS-1) / propanol-2 (99.8%, EKOS-1) in an ultrasonic (US) bath for 7 68 minutes for each solvent, followed by washing with deionized water and drying. Afterwards, the surfaces of the substrates were 69 cleaned in a "Piranha" solution (H₂SO₄: H₂O₂ (3: 1)) under US and a temperature of 50 °C for 15 minutes, then in a solution of NH₃ 70 (25% solution) : H₂O: H₂O₂ (3: 1: 1) at the ultrasound and a temperature of 50 °C within 15 minutes. The treated surface was

- 71 washed in a stream of deionized water and dried in the inert atmosphere.
- 72 The preliminary cleaning of the surface using the RCA1 method^{s3} was critical for forming a highly ordered silica monolayer. This
- ran be explained by the more intense removal of organic and inorganic surface impurities by the alternating action of oxidizing
- 74 agents, H_2SO_4 : H_2O_2 (3 : 1) and NH_3 (25% solution) : H_2O : H_2O_2 (3 : 1 : 1), respectively, and mechanical impurities by the action of
- 75 ultrasound due to the cavitation effect.^{s4}



81 Fig. S5. The estimation of a thickness (A) and topology (B) of the surface profile of PEI-modified surface in the microfludic channel.



84 Fig. S6. Silica layer deposition by dip-coating: (A) pristine Si₃N₄ substrate; (B) PAH-modified Si₃N₄ substrate; (C) PEI-modified Si₃N₄

$$v_{dip} = 41 \frac{mm}{min}; t_{incubation} = 7 min; v_{withdrawal} = 1 \frac{mm}{min}.$$

85 substrate (

86 Landau-Levich equation:

(1)

$$h = c \cdot \frac{(\eta \cdot \nu)^{2/3}}{\gamma_{lv}^{1/6} \cdot (\rho \cdot g)^{1/2}}$$

87 88

- 89 where h the film thickness; c non-dimensional empirical coefficient; η viscosity of medium; ν withdrawal rate of a Si₃N₄
- 90 substrate; $\gamma_{a/l}$ surface tension of air/liquid interface; ρ SiO₂ density; g gravity.

91 S4. CONVECTIVE ASSEMBLY IN MICROFLUIDICS

92 SEM images of the particles assembled inside a microfluidic channel of width 500 μm and height 500 μm are presented in Fig. S7.

93 The Si₃N₄ surfaces were pristine and cleaned using the substrate cleaning protocol. Here, we observed that the particles organized

94 separated island aggregates due to capillary forces and inert features of the silicon nitride surface. Additionally, **Fig. S10** 95 demonstrates aggregated non-homogeneous multilayer structures at the channel borders due to movement of the meniscus with

96 a flow rate slower than in the central part of the channel.





100 S5. SILICA COATINGS ON PEI and PSS MODIFIED SILICOM NITRIDE SURFACES101



103 Fig. S8. Silica deposition on the polyelectrolyte modified Si₃N₄ surface by microfluidic deposition: (A, B) PEI-modified channel; $v_{filling} = 5 \frac{\mu L}{min}; v_{outflow} = 50 \frac{\mu L}{h}; t_{stabilization} \approx 2 min;$ 104 (C, D) PSS-modified channel (the channel parameters: 500 µm ×

105 500 μm).



107 Fig. S9. Silica deposition on the PEI-modified Si₃N₄ surface by microfluidics under different suspension flow rates: (A)

$$v_{outflow} = 10 \frac{\mu L}{h}; \quad (B) \qquad v_{outflow} = 25 \frac{\mu L}{h}; \quad (C) \qquad v_{outflow} = 50 \frac{\mu L}{h}; \quad (D) \qquad v_{outflow} = 100 \frac{\mu L}{h} \quad (C)$$

 $v_{filling} = 5 \frac{1}{min}; t_{stabilization} \approx 2 min;$ 109 the channel parameters: 500 µm × 500 µm).



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Fig. S10. Microfluidic deposition silica layers PEI-modified 111 of on the SiaN surface. ($v_{filling} = 5 \frac{\mu L}{min}; v_{outflow} = 50 \frac{\mu L}{h}; t_{stabilization} \approx 2 min;$ the channel parameters: $500 \text{ um} \times 500 \text{ um}$) 112

113 S6 INFLUENCE OF THE FORMED SILICA MICROSPHERE LAYERS ON THE SENSOR PERFORMANCE

Synthesis and characterization of spherical submicron silica particles (SiO_2 SMPs) was demonstrated in our previously published work.⁵⁵ A comparison of particles' average diameters was provided *via* transmission electron microscopy (TEM) and dynamic light scattering (DLS) methods (299 ± 3 nm). Particle average diameters were not invariably similar due to the presence of aggregates, the number of which depends on the holding time of Si^O₂ SMP suspensions in an ultrasonic bath. The value of ζ -potential is - 56 ± 2 mV, which indicates high colloidal stability of the synthesized silica particles.

The uniformity in diameter and sphericity of the silica microspheres directly affects the average Q factor of the micro-ring 119 resonators. In the case of slightly changed diameters of SiO_2 SMPs (299 ± 3 nm), optical losses at the central wavelength equal 120 to 1550 nm will be negligible. **Fig. S11** demonstrates the results of the simulation for estimation of the influence of the SiO_2 SMPs 121 on the Q factor performed in COMSOL Multiphysics. A 2D model of the waveguide cross-section was used to calculate the effective 122 refractive index (n_{eff}) and attenuation constant for fundamental TE and TM modes, characterized the interaction of evanescent 123 optical mode with the SiO_2 SMPs. A low optical power loss signifies a high Q factor and sharper resonance peaks, which translates 124 to improving the limit of detection (LoD) caused by gas adsorption. Non-uniform particles would introduce variability in the 125 resonance conditions, broadening the resonance peaks and reducing the LoD. 126



Fig. S11. Optical characteristics of micro-ring resonators uncoated/coated by silica particles for one monolayer coating. Distribution of the normalized electric (A) and magnetic (B) field in the cross-section model of a semi-etched waveguide. (C) Dependence of attenuation constant on the radius of Si^{O_2} SMP. (D) Dependence of n_{eff} on the radius of Si^{O_2} SMP.

Besides uniform the diameter control of the SiO_2 SMPs, an optimal concentration was found to ensure a close-packed monolayer without causing agglomeration or multilayer formation (**Fig. S7-S10**). High concentration can lead to overlapping of particles, while low concentration might result in a defective monolayer with low coverage monolayer, both of which can degrade the sensing performance. A uniform and well-packed monolayer ensures consistent micro-ring resonances across the sensor, enhancing the overall sensitivity and reliability. Variations in particle concentration during the assembly process can lead to defects and non-uniformity in the monolayer, adversely affecting the Q factor and sensitivity.

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139 S7 GAS SENSING PERFORMANCE BY SILICA PARTICLES COATED MICRO-RING RESONATORS

To estimate the influence of CPCs on the optical characteristics of silicon nitride MRRs, and the gas sensing performance, the 140 following tasks were carried out: (1) monitoring the effect of CPC on MRR characteristics; (2) determining the relative shift of the 141 142 resonance position of MRRs due to introduction of saturated vapours of the studied analytes in the channel. All experimental work, such as film deposition and measurements were carried out at room temperature. For the first experiment, one of the 143 144 channels was chosen for coating and the other channel was left as a reference with uncoated MRRs for the next step. The optimal 145 channel geometry and flow rates were determined from the previous experiments with PEI-modified micro-channels on Si₃N₄ surface. In the second step, vapours were pumped through the channel by using a peristaltic pump, and transmission spectral 146 147 characteristics were measured. 148



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Fig. S12. Optical characteristics of micro-ring resonators uncoated/coated by silica particles. The comparison between the 151 152 transmitted spectra of MRR1, MRR2, MRR3, and MRR4 before (A) and after depositing PEI+SiO₂ cladding (B), correspondingly. There are four devices: MRR1 (gap = 1000 nm; $y_{shift} = 0 \ dB$), MRR2 (gap = 800 nm; $y_{shift} = 10 \ dB$), MRR3 (gap = 650 nm; 153 $y_{shift} = 5 \ dB$) and MRR4 (gap = 500 nm, $y_{shift} = 1 \ dB$). (C) Bar chart of the external quality factor of resonators before (air 154 cladding) and after PEI+SiO2 cladding deposition of the silica film. 155

For optimization of MRR geometry during PEI modification, the gaps between bus and ring waveguides were 1000 nm, 800 nm, 156 650 nm, and 500 nm for respective resonators going from left to right in both rows. The MRR on the far left of Fig. S10 is labeled 157 as MRR1, and consequently, the devices going from left to right are labeled as MRR2 to MRR 4. The left end of the micro-channels 158 159 was used as the inlet, and the opposite end was used as the outlet. As it was demonstrated in the recent works, s6-s8 the chip was kept constant during the experiment. The microfluidic-nanophotonic sensor was placed upon an adjustable 3D stage with a heater 160 and thermometer. The proportional-integral-derivative PID controller was used for stabilizing the temperature on the table to be 161 162 equal to 25°C. To provide TE single-mode propagation regime, focusing grating couplers with an efficiency of 18% to input & 163 output optical radiation from the photonic chip were used.⁵⁹ The polarization controller was used to achieve maximum signal at transmission, which corresponded to the TE - mode. Fig. S12 A, B demonstrates the transmission spectrum for MRRs with different 164 165 gaps in case of uncoated/coated by silica particles of sensitive sensor surface. It was found that the deposition of silica particles to the sensitive surface of the device and gap area did not lead to significant changes in the transmission spectrum of the PIC 166 structure. In contrast, the quality factor of the MRRs is sharply reduced with the deposition of silica particles, which makes it 167 168 impossible to operate devices with wide gaps (Fig. S12 C).



173 channel parameters: 500 μ m \times 500 μ m).

174 Firstly, the photonic chip with MRRs and PDMS chip were manually stacked together by using a custom holder with adjustable XYZ coordinates and angle in the XY coordinates. The microfluidic chip contained two 13 mm long, 500 μm wide, and 500 μm high 175 micro-channels. The channels were aligned such that the centers of MRRs of both rows (see Fig. S13), coincided with the center 176 of the channels. The colloidal suspension was first slowly pumped inside the channel at a flow rate of 10 µL/min and withdrawn 177 178 at a flow rate of 50 µL/h. During experiments, the temperature of the copper stage was slowly increased to 60°C and left for drying for one hour. Afterward, the chip was slowly cooled down to room temperature, again heated for a few minutes at 60°C after 179 depositing coating in one of the channels. 180

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182 The formation of the hcp silica layer on the surface might be an extremely complex process even on a planar substrate surface. Particularly, the principles of dense layer formation are in conjunction of the DLVO theory, the Derjaguin-Muller-Toporov adhesion 183 theory, the Johnson-Kendal-Roberts theory, and the stability of laminar flow in the micro-channels. Therefore, taking into account 184 the aspects of these theoretical models and the complicated structure of the nano-patterned surface of the micro-ring resonators 185 and waveguides, we would like to note some significant parameters, which might affect the lattice structure of silica CPC on the 186 187 micro-ring resonators.

First, the preliminary modification of the Si₃N₄ surface by PEI for the surface of the channels creates additional contacts between 188 individual particles and the walls of nano-patterned cavities, particularly by electrostatic interaction between them and due to 189 the artificial surface roughness of the nano-patterned surface (see Fig. S5). Additionally, we may estimate the ratio heta between 190 191 the number of silica particles in the suspension and the maximum number of surface sites for hcp formation of CPC. As the depth 192 of the nano-pattern is 225 ± 12 nm which is less than the diameter of an individual particle (d = 300 nm), we may conclude that 193 the walls of the nano-patterned cavities do not provide the additional sites for adhesion of the particles. Considering the 194 dimensions $l \times w \times h$ of the microfluidic channel equal to $10 \times 0.5 \times 0.5$ mm, we calculate the ratio between the number of silica particles in the suspension N_{SiO2} and the number of active sites N_{sites} according to Equations 2 – 4: 195

$$N_{SiO2} = \frac{C_{SiO2} \cdot l \cdot w \cdot h}{\frac{4}{3}\pi \cdot R^3 \cdot \rho_{SiO2}}$$
(2)

$$N_{sites} = \frac{\varphi \cdot \iota \cdot w}{\pi \cdot R^2} \tag{3}$$

. . .

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$$\theta = \frac{N_{SiO2}}{N_{sites}} \approx 1.6 \cdot 10^3 \tag{4}$$

198

199 where $l \cdot w \cdot h$ - dimensions of the micro-channel; c_{SiO2} - concentration of the silica particles in the ethanol suspension; 200 R = 150 nm - radius of an individual particle; $\rho_{SiO2} \approx 2 \frac{g}{cm^3}$ - density of amorphous silica; $\varphi \approx 90.7\%$ - maximum

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200 R = 150 nm – radius of an individual particle; r^{1502} / cm^{3} – density of amorphous silica; $\varphi \approx 90.7\%$ – maximum 201 coefficient of the surface coverage for *hcp* lattice. Thus, in these conditions, the number of silica particles is 1000 times more than 202 the surface sites. This estimation demonstrates that such an excess concentration of silica particles might be sufficient for forming 203 the *hcp* lattice structure of CPC.



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Fig. S14. The micro-ring resonator configuration (A) and silica layers deposited on the micro-ring resonator surfaces with a gap of 1000 nm (B), 800 nm (C), 650 nm (D), and 500 nm (E).

- 208 Furthermore, the structure of micro-ring resonators is quite complex for the estimation of regularities for forming *hcp* layers and
- 209 depends on the point, where we want to estimate the CPC formation. Here, we assessed how the CPC structure differs at the
- 210 contact area between the bus waveguide and MRR (Fig. S14 A) and the perpendicular area of the MRR towards the suspension
- 211 flow (Fig. S15 A). Analyzing the first configuration of nano-patterns and suspension flow, we observed that the CPC structure
- inside the micro-ring and bus waveguide cavities is similar to the CPCs on the planar areas of the Si_3N_4 surface. This fact might be explained due to the parallel position of the cavity lines towards the particle flow, i.e., the dislocations in the CPC structure may
- be defined by the narrowest cavities such as the gaps between the MRR and bus waveguides (**Fig. S14 B-E**). If the width of the
- gap is less than the doubled diameter of the particle (< 600 nm), then silica particles can not be placed in the closely packed
- 216 structure and this provokes the formation of multilayers in the gap cavities.
- 217 Considering the configuration of the perpendicular orientation of the MRR cavities towards the flow (**Fig. S15 B**), we suggest that 218 in this case, the turbulent flows might appear close to the surface. Such deflection of flow state from the laminar regime to a 219 turbulent one can provide stochastic changes in the direction and velocity of the particles in the channel. We constructed the 220 COMSOL model of the flow distribution of pure ethanol in the studied microfluidic channel and surface patterns (**Fig. S15 C**, **D**), 221 and assessed the possibility of the appearance of the additional vorticity fields near the Si₃N₄ surface. Wherein, we assumed the 222 laminar regime of the flow at the input of the channel (*Reynolds number*, Re = 500). The additional vorticity fields as well
- as the fluid pressure increase were observed at the borders of the nano-patterned cavities. Thus, we confirmed the formation of
- turbulent flows, which might improve the structure of the CPC lattice inside the cavities, although to make the dislocations for
- the CPC structure on the total chip surface due to the random behaviour of particle flows.



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Fig. S15. The micro-ring resonator configuration (A) and silica layers deposited on the micro-ring resonator surface (B). Distribution of vorticity flow field (C) and fluid pressure (D) for the ethanol flow in the microfluidic channels modeling by COMSOL Multiphysics (*Reynolds number*, Re = 500).



Fig. S16. Experimental setup for gas sensing performance with silica monolayers modified O-ring resonators. The dashed black 233 234 lines indicate electronic connections, blue lines-microfluidic, and orange lines optical fiber connections.

To understand the effects of PEI modification and convective assembly, first, the transmission spectrum of all four devices was 235

measured when there was only DI water in the channels. Following DI water, measurements were carried out before as well as 236

after 20 minutes of pumping 1 mg/ml solution of PEI in DI water. Furthermore, the channel was washed by pumping DI water for 237

238 10 minutes. All reagents were pumped at a flow rate of 20 µL/min, except the colloidal silica suspension. Similarly, the transmission

spectra were measured after convective assembly of particles and drying for one hour. 239

In the second part of the experiment, the setup consisted of main elements presented in Fig. S16. Mainly, three types of analyte 240

241 vapours were used, i.e., DI water, ethanol, and acetone. A peristaltic pump and Drexel flask containing the studied analyte were connected in series with the inlet of the microfluidic setup. The air from the surroundings was pumped inside the liquid analyte 242

243 to form air bubbles that quickly become saturated with the analyte molecules, compared to conventional vapours evaporated

244 from a bulk surface. Another tube connected the microfluidic channels with the Drexel flask, and the saturated vapours were

pumped towards the sensing elements. 245



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248 Initially, measurements without air flow in the channels were performed and used as a reference point. Following that, the 249 transmission spectrum of MRR was measured after five minutes of pumping water vapours at the flow rate of 20 µL/min. Before 250

proceeding to the next analyte, the room air inside the channel was pumped at 100 µL/min to observe the effects of air flow on

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251 capillary condensation of analytes. Similarly, the vapours of ethanol and acetone were introduced respectively after five minutes

252 of air flow to determine their effects on condensed analytes.

253 S8 ADVANTAGE OF THE PROPOSED CONCEPT

254 Many methods for breath analysis have been explored throughout the last decade, from the earliest methods, as for instance, gas chromatography coupled with mass spectrometers, ^{s10} to the most recent ones, such as electronic noses (E-noses).^{s11} However, 255 256 the limitations of mass spectrometry include its inability to differentiate between two volatile compounds that share the same 257 most pronounced mass-to-charge ratio, potentially leading to ambiguities in compound identification. In turn, despite the advantages of E-noses related to high sensitivity and cost-effectiveness, E-noses suffer from several significant drawbacks, e.g., a 258 259 need for a training prior to the use and proper calibration to cope with the discreteness.^{\$12} Other than conventional methods, 260 optical spectroscopic methods using lasers have also been the center of attention.⁵¹³ Despite that, such techniques are not 261 portable, rather complex and expensive. PIC-based sensors majorly operate based on the refractive index changes in a surface 262 layer of waveguides. This is a method similar to laser spectroscopic techniques, information of gases can be gathered based on 263 the absorption occurring in an optical mode of the waveguide. Although, the main challenge is to reach lower limits of detection. To overcome this challenge, modification of the surface of the photonic circuits is commonly applied. Mostly, chemically 264 265 functionalized nano-porous materials,^{\$14} analyte-sensitive organic material,^{\$15} or metal-organic framework coatings^{\$16} are preferred. The activity in these areas indicates that with chemically functionalized porous coatings and their combination with 266 the PICs, gas sensors for biomedical applications can be fully realized. However, this still poses similar issues to that of chemical 267 268 semiconductor sensors. The performance of chemisorption-based sensing elements always deteriorates over time.

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270 Table S1. Colloidal Photonic Crystals (CPCs) for gas sensing applications

Sensor signal generation	Sensing material	CPC formation method	Detected analytes	Reference
Whispering gallery mode	Mesoporous SiO ₂ microspheres decorated by Pd nanoparticles	Dip-coating	Hydrogen	[\$16]
Bragg stacks	Mesoporous SiO ₂ nanoparticles and TiO ₂ sols	Spin-coating	Toluene	[s17]
Resistivity / Reflectance	PEDOT/PPy inverse opals	Electrodeposition	Ammonia	[\$18]
Bragg stacks	Alternating SiO ₂ / TiO ₂ nanoparticle layers functionalized with different alkoxysilanes	Spin-coating	Alcohols / Volatiles from bacteria species	[\$19]
Bragg stacks	SiO ₂ monolayer on Ta ₂ O ₅ /SiO ₂ photonic crystal surface	Dip-coating	Acetone, Ammonia, Ethanol, 2-Propanol	[s5]
Transmittance / Bragg peak wavelength shift	Polystyrene nanoparticle monolayer	Dip-coating	Ethanol	[s20]
Bragg stacks	Alternating layers of amorphous poly(p-	Spin-coating	Carbon tetrachloride, benzene, 1,2-	[s21]

	phenylene oxide) and	dichlorobenzene			
	cellulose acetate				
271					
272	The developed sensor based on a combination of PICs and micro	fluidics has the potential to bring new opportunities in gas			
273	sensing, and various other sectors including colloidal science, thin film coatings on inert surfaces, gas sensing, colloidal photonic				
274	crystals for photonic integrated circuits with new functionalities, t				
275	Microfluidic convective assembly helps to achieve the specific patter				
276	coefficient of up to 59%. In addition, the integration of CPC wit	h PIC on ${}^{\mathcal{S}l_3N_4}$ platform enhances the optical PIC sensing			
277	capabilities in terms of sensitivity and specificity due to leveraging	the unique properties of CPCs, coupled with the high optical			
278	transparency of Si_3N_4 in the near IR range.				
279					
280	In terms of real-time operation, this sensor will handle each analyt	e differently depending on changes in the effective refractive			
281	index of the surface layer. Fig. S18 shows the dependence of the relation	ative shift of resonance positions in the transmission spectrum			
282	of MRRs recorded by introducing DI water, ethanol, and acetone va	oours. Relying on the average change in the relative resonance			
283	position shift over time and on the experimental noise of the setup				
284	^{s8} the average response time of the system for ethanol vapours is	\approx 7 s, for acetone vapours \approx 18 s, respectively. Compared to			
285	other sensor systems for real-time ethanol vapour detection, the c				
286	to commercially available electrochemical (< 30 s), ^{s23} semiconducto	ors (60 - 90 s) ^{s24} and optical sensors (6 s) ^{s25} for exhaled breath			
287	analysis on the alcohol intoxication degree. Still, the evaluation of th	e determination range and the number of cycles of continuous			
288	operation of the proposed sensor requires extra studies.				
289					

Additionally, we estimated the analytical characteristics of the proposed sensor. Here, the micro-ring with the deposited silica layer is exposed to the saturated vapours of acetone and ethanol. To estimate the pressure of the saturated vapours in the micro-

292 channels we used the Antoine equation.^{s26} Applying the assumption of the ideal gas, the sensitivity coefficients were equal to -

293 5.9·10⁻⁴ pm/ppm and -5.7·10⁻⁵ pm/ppm for ethanol and acetone vapours, respectively. That means such sensing configuration is

294 ~10 times sensitive to ethanol vapours than to acetone ones. This is supported by the values of LoD for ethanol and acetone which 295 are equal to 5.1·10³ ppm and 53·10³ ppm, accordingly.



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Fig. S18. Gas sensing performance for micro-ring resonators coated and uncoated by SiO₂ film: Relative shift of resonance positions in the transmission spectrum of modified MRR recorded by introducing DI water, ethanol, and acetone vapours. The blue dashed line showed the shifting of the resonance position of the ring waveguides coated by SiO₂ monolayers. The red and

300 green solid lines showed the shifting of the resonance position of the ring waveguides coated by SiO₂ monolayers for ethanol and

301 acetone vapours, respectively. α_1 (-8.93 pm/min) and α_2 (-3.35 pm/min) are the derivatives of the resonance shift over time for

302 the modified sensor for the ethanol and acetone vapours, respectively. Error bars coloured blue solid line are the standard

303 deviation of coated MRRs.

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